

M28LV16

NOT FOR NEW DESIGN

16K (2K x 8) LOW VOLTAGE PARALLEL EEPROM with SOFTWARE DATA PROTECTION

- FAST ACCESS TIME: 200ns
- SINGLE LOW VOLTAGE OPERATION
- LOW POWER CONSUMPTION
- FAST WRITE CYCLE:
 - 64 Bytes Page Write Operation
 - Byte or Page Write Cycle: 3ms Max
- ENHANCED END OF WRITE DETECTION:
 - Data Polling
 - Toggle Bit
- PAGE LOAD TIMER STATUS BIT
- HIGH RELIABILITY SINGLE POLYSILICON, CMOS TECHNOLOGY:
 - Endurance >100,000 Erase/Write Cycles
 - Data Retention >40 Years
- JEDEC APPROVED BYTEWIDE PIN OUT
- SOFTWARE DATA PROTECTION
- M28LV16 is replaced by the products described on the document M28C16A

DESCRIPTION

The M28LV16 is a 2K x 8 low power Parallel EEPROM fabricated with SGS-THOMSON proprietary single polysilicon CMOS technology. The device offers fast access time with low power dissipation and requires a 2.7V to 3.6V power supply. The circuit has been designed to offer a flexible microcontroller interface featuring both hardware and software handshaking with Data Polling and Toggle Bit. The M28LV16 supports 64 byte page write operation. A Software Data Protection (SDP) is also possible using the standard JEDEC algorithm.

	-
A0 - A10	Address Input
DQ0 - DQ7	Data Input / Output
W	Write Enable
Ē	Chip Enable
G	Output Enable
RB	Ready / Busy
V _{CC}	Supply Voltage
Vss	Ground

Table 1. Signal Names

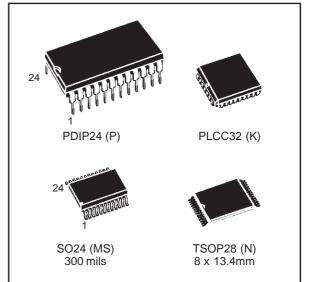
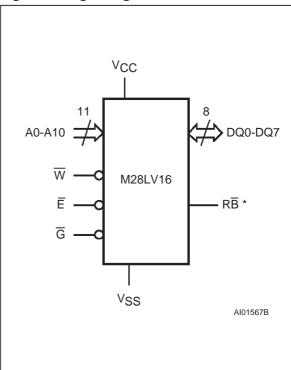


Figure 1. Logic Diagram



Note: * RB function is offered only with TSOP28 package.

November 1997

This is information on a product still in production but not recommended for new design.

Figure 2A. DIP Pin Connections

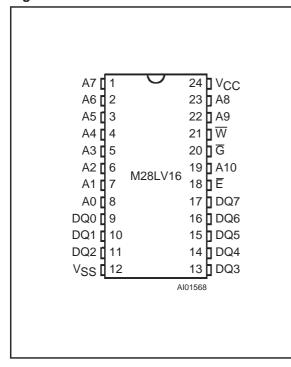
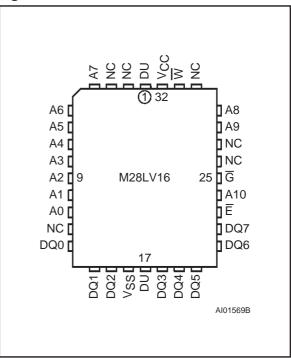


Figure 2B. LCC Pin Connections



Warning: NC = Not Connected, DU = Don't Use.

Figure 2C. SO Pin Connections

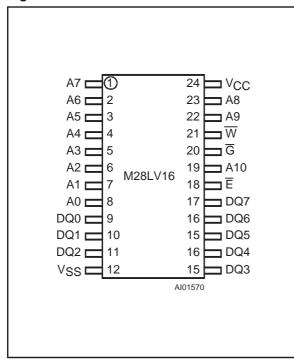
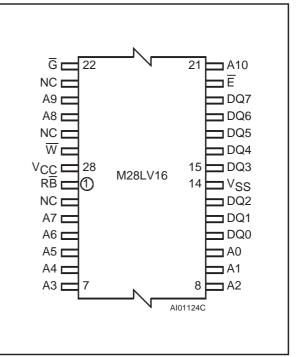


Figure 2D. TSOP Pin Connections



Warning: NC = Not Connected.

 Table 2. Absolute Maximum Ratings ⁽¹⁾

Symbol	Parameter	Value	Unit
T _A	Ambient Operating Temperature	– 40 to 85	°C
T _{STG}	Storage Temperature Range	– 65 to 150	°C
Vcc	Supply Voltage	-0.3 to 6.5	V
V _{IO}	Input/Output Voltage	- 0.3 to V _{CC} +0.6	V
VI	Input Voltage	-0.3 to 6.5	V
V _{ESD}	Electrostatic Discharge Voltage (Human Body model) ⁽²⁾	4000	V

Note: 1. Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the SGS-THOMSON SURE Program and other relevant quality documents.

2. 100pF through 1500Ω; MIL-STD-883C, 3015.7

Table 3. Operating Modes ⁽¹⁾

Mode	Ē	G	W	DQ0 - DQ7
Standby	1	Х	Х	Hi-Z
Output Disable	Х	1	Х	Hi-Z
Write Disable	Х	Х	1	Hi-Z
Read	0	0	1	Data Out
Write	0	1	0	Data In

Note: 1. $0 = V_{IL}$; $1 = V_{IH}$; $X = V_{IL}$ or V_{IH} .

PIN DESCRIPTION

Addresses (A0-A10). The address inputs select an 8-bit memory location during a read or write operation.

Chip Enable (Ē). The chip enable input must be low to enable all read/write operations. When Chip Enable is high, power consumption is reduced.

Output Enable (\overline{G}) . The Output Enable input controls the data output buffers and is used to initiate read operations.

Data In/ Out (DQ0 - DQ7). Data is written to or read from the M28LV16 through the I/O pins.

Write Enable (W). The Write Enable input controls the writing of data to the M28LV16.

Ready/Busy (RB). Ready/Busy is an open drain output that can be used to detect the end of the internal write cycle.

It is offered only with the TSOP28 package. The reader should refer to the M28LV17 datasheet for more information about the Ready/Busy function.

OPERATION

In order to prevent data corruption and inadvertent write operations during power-up, a Power On Reset (POR) circuit resets all internal programming cicuitry. Access to the memory in write mode is allowed after a power-up as specified in Table 7.

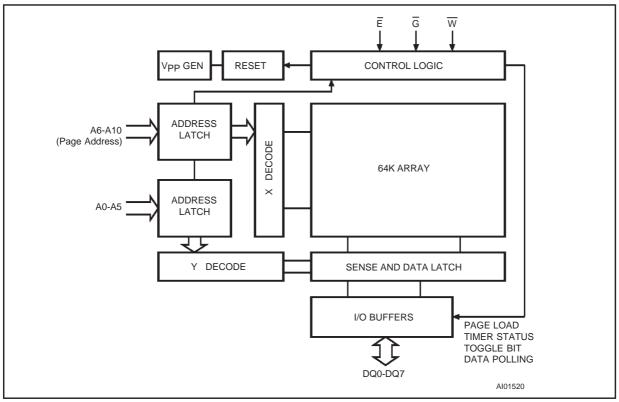
Read

The M28LV16 is accessed like a static RAM. When \overline{E} and \overline{G} are low with \overline{W} high, the data addressed is presented on the I/O pins. The I/O pins are high impedance when either \overline{G} or \overline{E} is high.

Write

Write operations are initiated when both \overline{W} and \overline{E} are low and \overline{G} is high. The M28LV16 supports both \overline{E} and \overline{W} controlled write cycles. The Address is latched by the falling edge of \overline{E} or \overline{W} which ever occurs last and the Data on the rising edge of \overline{E} or \overline{W} which ever occurs first. Once initiated the write operation is internally timed until completion.

Figure 3. Block Diagram



Page Write

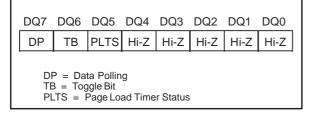
Page write allows up to 64 bytes to be consecutively latched into the memory prior to initiating a programming cycle. All bytes must be located in a single page address, that is A6-A10 must be the same for all bytes. The page write can be initiated during any byte write operation.

Following the first byte write instruction the host may send another address and data with a minimum data transfer rate of $1/t_{WHWH}$ (see Figure 13). If a transition of \overline{E} or \overline{W} is not detected within t_{WHWH} , the internal programming cycle will start.

Microcontroller Control Interface

The M28LV16 provides two write operation status bits and one status pin that can be used to minimize the system write cycle. These signals are available on the I/O port bits DQ7 or DQ6 of the memory during programming cycle only.

Figure 4. Status Bit Assignment



Data Polling bit (DQ7). During the internal write cycle, any attempt to read the last byte written will produce on DQ7 the complementary value of the previously latched bit. Once the write cycle is finished the true logic value appears on DQ7 in the read cycle.

Toggle bit (DQ6). The M28LV16 offers another way for determining when the internal write cycle is completed. During the internal Erase/Write cycle, DQ6 will toggle from "0" to "1" and "1" to "0" (the first read value is "0") on subsequent attempts to read the memory. When the internal cycle is completed the toggling will stop and the device will be accessible for a new Read or Write operation.

Page Load Timer Status bit (DQ5). In the Page Write mode data may be latched by \overline{E} or \overline{W} . Up to 32 bytes may be input. The Data output (DQ5) indicates the status of the internal Page Load Timer. DQ5 may be read by asserting Output Enable Low (t_{PLTS}). DQ5 Low indicates the timer is running, High indicates time-out after which the write cycle will start and no new data may be input.



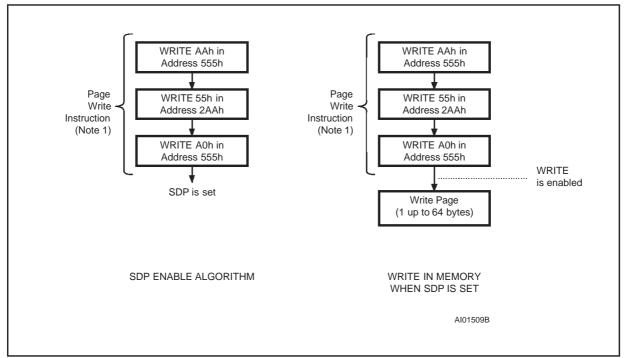
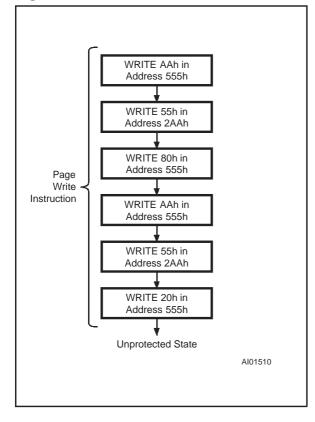


Figure 5. Software Data Protection Enable Algorithm and Memory Write

Note: 1. MSB Address bits (A6 to A10) differ during these specific Page Write operations.

Figure 6. Software Data Protection Disable Algorithm



Software Data Protection

The M28LV16 offers a software controlled write protection facility that allows the user to inhibit all write modes to the device including the Chip Erase instruction. This can be useful in protecting the memory from inadvertent write cycles that may occur due to uncontrolled bus conditions.

The M28LV16 is shipped as standard in the "unprotected" state meaning that the memory contents can be changed as required by the user. After the Software Data Protection enable algorithm is issued, the device enters the "Protect Mode" of operation where no further write commands have any effect on the memory contents. The device remains in this mode until a valid Software Data Protection (SDP) disable sequence is received whereby the device reverts to its "unprotected" state. The Software Data Protection is fully nonvolatile and is not changed by power on/off sequences.

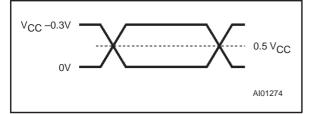
To enable the Software Data Protection (SDP) the device requires the user to write (with a Page Write) three specific data bytes to three specific memory locations as per Figure 5. Similarly to disable the Software Data Protection the user has to write specific data bytes into six different locations as per Figure 6 (with a Page Write). This complex series ensures that the user will never enable or disable the Software Data Protection accidentally.

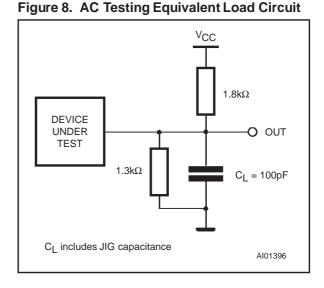
Table 4. AC Measurement Conditions

Input Rise and Fall Times	≤ 20ns
Input Pulse Voltages	0V to V _{CC} -0.3V
Input and Output Timing Ref. Voltages	1.5V

Note that Output Hi-Z is defined as the point where data is no longer driven.

Figure 7. AC Testing Input Output Waveforms





57

Table 5. Capacitance ⁽¹⁾ ($T_A = 25 \text{ °C}, f = 1 \text{ MHz}$)

Symbol	Parameter	Test Condition	Min	Мах	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0V$		6	pF
Соит	Output Capacitance	V _{OUT} = 0V		12	pF

Note: 1. Sampled only, not 100% tested.

Table 6. Read Mode DC Characteristics

 $(T_A = 0 \text{ to } 70^{\circ}\text{C or } -40 \text{ to } 85^{\circ}\text{C}; V_{CC} = 2.7\text{V to } 3.6\text{V})$

Symbol	Parameter	Test Condition	Min	Max	Unit
ILI	Input Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		10	μΑ
ILO	Output Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		10	μΑ
Icc ⁽¹⁾	Supply Current	$\overline{E} = V_{IL}, \ \overline{G} = V_{IL}, \ f = 5 \ MHz, \ V_{CC} = 3.3 V$		8	mA
100	(CMOS inputs)	$\overline{E} = V_{IL}, \ \overline{G} = V_{IL}, \ f = 5 \ MHz, \ V_{CC} = 3.6 V$		10	mA
I _{CC2} ⁽¹⁾	Supply Current (Standby) CMOS	\overline{E} > V _{CC} –0.3V		50	μΑ
VIL	Input Low Voltage		- 0.3	0.6	V
VIH	Input High Voltage		2	V _{CC} +0.5	V
V _{OL}	Output Low Voltage	I _{OL} = 1 mA		0.2 V _{CC}	V
Vон	Output High Voltage	I _{OH} = 1 mA	0.8 V _{CC}		V

Note: 1. All I/O's open circuit.

Table 7. Power Up Timing ⁽¹⁾ ($T_A = 0$ to 70°C or -40 to 85°C; $V_{CC} = 2.7V$ to 3.6V)

Symbol	Parameter	Min	Мах	Unit
t _{PUR}	Time Delay to Read Operation	1		μs
t _{PUW}	Time Delay to Write Operation	10		ms
V _{WI}	Write Inhibit Threshold	1.5	2.5	V

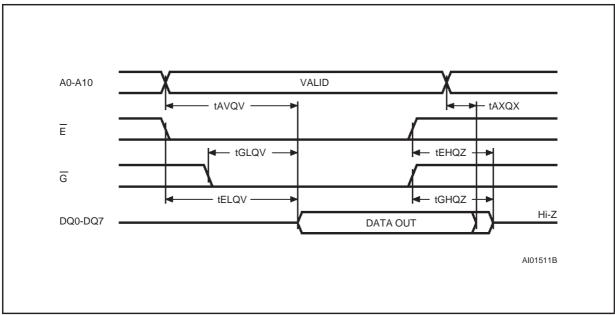
Note: 1. Sampled only, not 100% tested.

Table 8. Read Mode AC Characteristics

						M28	LV16			
Symbol	Alt	Parameter	Test Condition	-2	00	-2	50	-3	00	Unit
				Min	Мах	Min	Мах	Min	Max	
t _{AVQV}	t _{ACC}	Address Valid to Output Valid	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$		200		250		300	ns
t _{ELQV}	t _{CE}	Chip Enable Low to Output Valid	$G = V_{IL}$		200		250		300	ns
t _{GLQV}	t _{OE}	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		100		150		150	ns
t _{EHQZ} ⁽¹⁾	t _{DF}	Chip Enable High to Output Hi-Z	$\overline{G} = V_{IL}$	0	55	0	60	0	60	ns
t _{GHQZ} ⁽¹⁾	t _{DF}	Output Enable High to Output Hi-Z	$\overline{E} = V_{IL}$	0	55	0	60	0	60	ns
t _{AXQX}	t _{OH}	Address Transition to Output Transition	$\overline{E} = V_{IL}, \overline{G} = V_{IL}$	0		0		0		ns

Note: 1. Output Hi-Z is defined as the point at which data is no longer driven.

Figure 9. Read Mode AC Waveforms



Note: Write Enable (\overline{W}) = High

Symbol	Alt	Parameter	Test Condition	Min	Мах	Unit
t _{AVWL}	t _{AS}	Address Valid to Write Enable Low	$\overline{E} = V_{IL}, \overline{G} = V_{IH}$	0		ns
tavel	t _{AS}	Address Valid to Chip Enable Low	$\overline{G}=V_{IH},\overline{W}=V_{IL}$	0		ns
t _{ELWL}	t _{CES}	Chip Enable Low to Write Enable Low	Chip Enable Low to Write Enable Low $\overline{G} = V_{IH}$			
t _{GHWL}	toes	Output Enable High to Write Enable Low	0		ns	
t _{GHEL}	t _{OES}	Output Enable High to Chip Enable Low	$\overline{W}=V_{IL}$	0		ns
t _{WLEL}	t _{WES}	Write Enable Low to Chip Enable Low	$\overline{G} = V_{IH}$	0		ns
t _{WLAX}	t _{AH}	Write Enable Low to Address Transition		100		ns
t _{ELAX}	t _{AH}	Chip Enable Low to Address Transition		100		ns
t _{WLDV}	t _{DV}	Write Enable Low to Input Valid	$\overline{E}=V_{IL},\overline{G}=V_{IH}$		1	μs
t _{ELDV}	t _{DV}	Chip Enable Low to Input Valid	$\overline{G}=V_{IH},\overline{W}=V_{IL}$		1	μs
t _{ELEH}	t _{WP}	Chip Enable Low to Chip Enable High		100	1000	ns
twhen	t _{CEH}	Write Enable High to Chip Enable High		0		ns
twhgl	tоен	Write Enable High to Output Enable Low		0		ns
tehgl	tоен	Chip Enable High to Output Enable Low		0		ns
t _{EHWH}	t _{WEH}	Chip Enable High to Write Enable High		0		ns
twhdx	t _{DH}	Write Enable High to Input Transition		0		ns
t _{EHDX}	t _{DH}	Chip Enable High to Input Transition		0		ns
twnw∟	t _{WPH}	Write Enable High to Write Enable Low		50		ns
t _{WLWH}	t _{WP}	Write Enable Low to Write Enable High		100		ns
t _{WHWH}	t _{BLC}	Byte Load Repeat Cycle Time		0.2	100	μs
twhrh	twc	Write Cycle Time			3	ms
t _{DVWH}	t _{DS}	Data Valid before Write Enable High		50		ns
t _{DVEH}	t _{DS}	Data Valid before Chip Enable High		50		ns

Table 9. Write Mode AC Characteristics $(T_A = 0 \text{ to } 70^{\circ}\text{C} \text{ or } -40 \text{ to } 85^{\circ}\text{C}; V_{CC} = 2.7\text{V to } 3.6\text{V})$



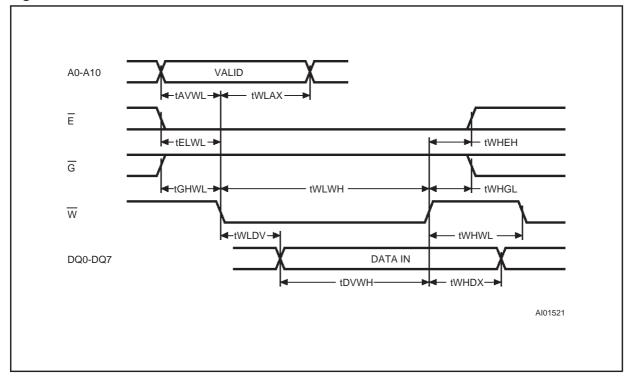
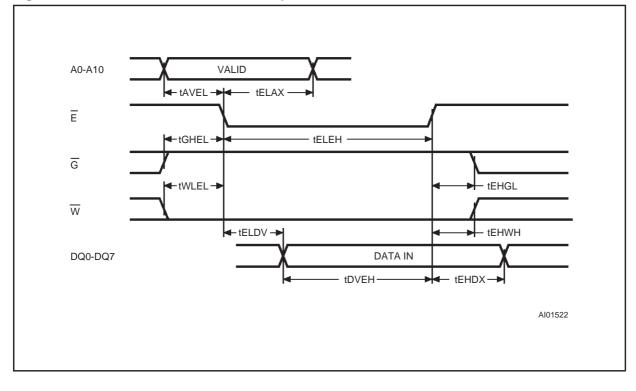


Figure 10. Write Mode AC Waveforms - Write Enable Controlled

Figure 11. Write Mode AC Waveforms - Chip Enable Controlled



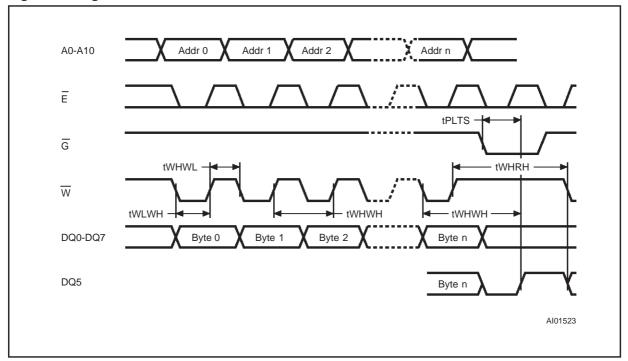
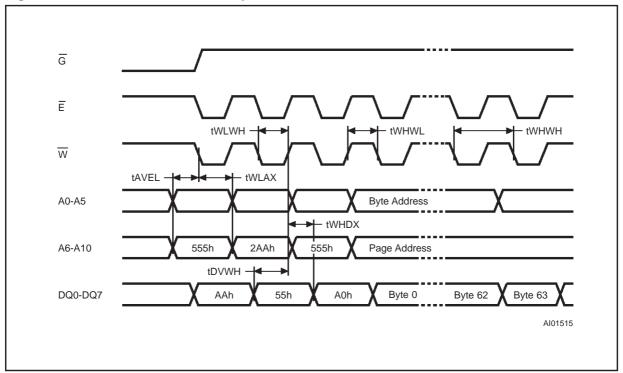


Figure 12. Page Write Mode AC Waveforms - Write Enable Controlled

Figure 13. Software Protected Write Cycle Waveforms



Note: A6 through A10 must specify the same page address during each high to low transition of \overline{W} (or \overline{E}) after the software code has been entered. \overline{G} must be high only when \overline{W} and \overline{E} are both low.

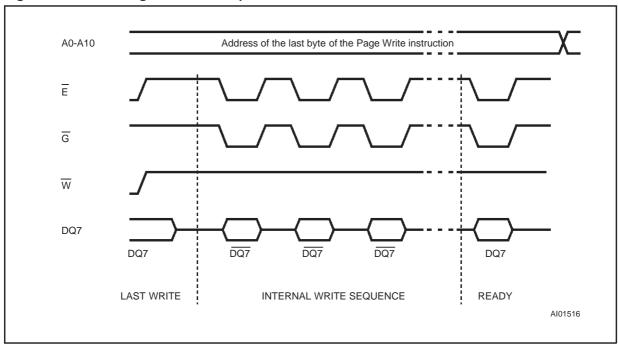
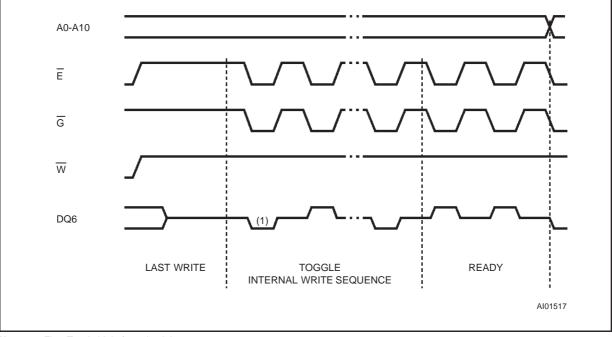


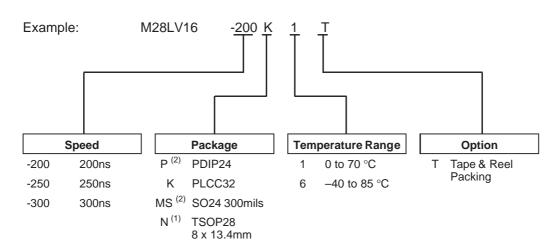
Figure 14. Data Polling Waveform Sequence





Note: 1. First Toggle bit is forced to '0'

ORDERING INFORMATION SCHEME



Notes: 1. The M28LV16 in TSOP28 package has a Ready/Busy output on pin 1. 2. Packages available on request only.

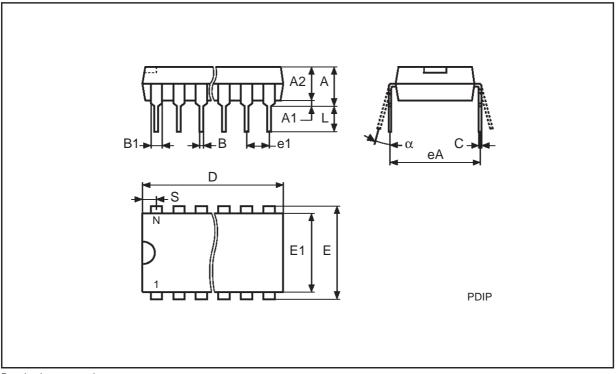
Devices are shipped from the factory with the memory content set at all "1's" (FFh).

For a list of available options (Package, etc...) or for further information on any aspect of this device, please contact the SGS-THOMSON Sales Office nearest to you.

Symb		mm			inches			
Synto	Тур	Min	Мах	Тур	Min	Max		
А		3.94	5.08		0.155	0.200		
A1		0.38	1.78		0.015	0.070		
A2		3.56	4.06		0.140	0.160		
В		0.38	0.56		0.015	0.021		
B1		1.14	1.78		0.045	0.070		
С		0.20	0.30		0.008	0.012		
D			32.26			1.270		
E		14.80	16.26		0.583	0.640		
E1		12.50	13.97		0.492	0.550		
e1	2.54	-	_	0.100	-	_		
eA		15.20	17.78		0.598	0.700		
L		3.05	3.82		0.120	0.150		
S		1.02	2.29		0.040	0.090		
α		0°	15°		0°	15°		
N		24			24			

PDIP24 - 24 pin Plastic DIP, 600 mils width

PDIP24

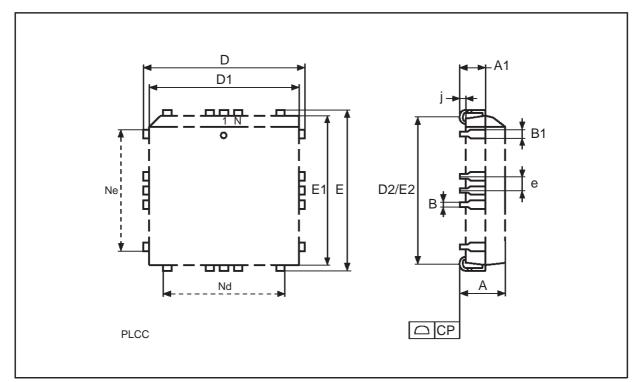


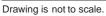
Drawing is not to scale.

Symb	mm			inches			
Synib	Тур	Min	Max	Тур	Min	Мах	
А		2.54	3.56		0.100	0.140	
A1		1.52	2.41		0.060	0.095	
В		0.33	0.53		0.013	0.021	
B1		0.66	0.81		0.026	0.032	
D		12.32	12.57		0.485	0.495	
D1		11.35	11.56		0.447	0.455	
D2		9.91	10.92		0.390	0.430	
E		14.86	15.11		0.585	0.595	
E1		13.89	14.10		0.547	0.555	
E2		12.45	13.46		0.490	0.530	
е	1.27	-	-	0.050	_	-	
j	0.89	-	-	0.035	_	_	
N		32			32		
Nd	7				7		
Ne		9		9			
СР			0.10			0.004	

PLCC32 - 32 lead Plastic Leaded Chip Carrier, rectangular

PLCC32

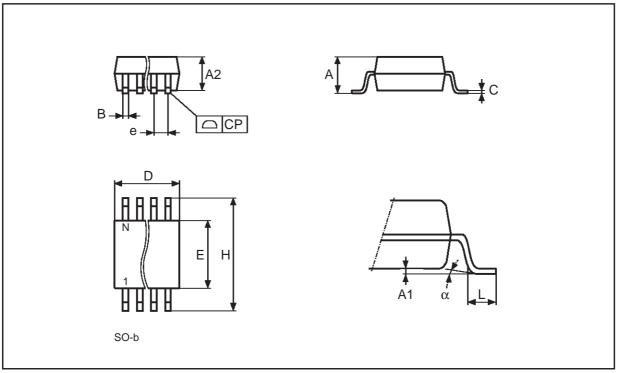




Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Мах
А		2.46	2.64		0.097	0.104
A1		0.13	0.29		0.005	0.011
A2		2.29	2.39		0.090	0.094
В		0.35	0.48		0.014	0.019
С		0.23	0.32		0.009	0.013
D		15.20	15.60		0.598	0.614
Е		7.42	7.59		0.292	0.299
е	1.27	-	-	0.050	-	-
Н		10.16	10.41		0.400	0.410
L		0.61	1.02		0.024	0.040
α		0°	8°		0°	8°
Ν	24			24		
CP			0.10			0.004

SO24 - 24 lead Plastic Small Outline, 300 mils body width

SO24

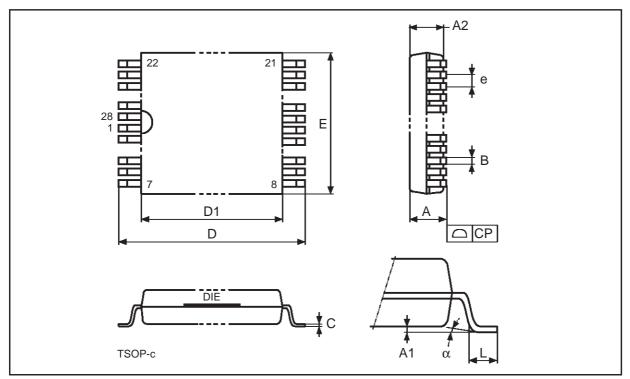


Drawing is not to scale.

Symb	mm			inches		
	Тур	Min	Max	Тур	Min	Мах
А			1.25			0.049
A1			0.20			0.008
A2		0.95	1.15		0.037	0.045
В		0.17	0.27		0.007	0.011
С		0.10	0.21		0.004	0.008
D		13.20	13.60		0.520	0.535
D1		11.70	11.90		0.461	0.469
E		7.90	8.10		0.311	0.319
е	0.55	-	-	0.022	_	-
L		0.50	0.70		0.020	0.028
α		0°	5°		0°	5°
N	28			28		
СР			0.10			0.004

TSOP28 - 28 lead Plastic Thin Small Outline, 8 x 13.4mm

TSOP28



Drawing is not to scale.

Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectronics.

© 1997 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES Australia - Brazil - Canada - China - France - Germany - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands -Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A.